

Search Notes

Application/Control No.

10/767,231

Examiner

Amine Riad

Applicant(s)/Patent under
Reexamination

DERKS ET AL.

Art Unit

2113

SEARCHED

Class	Subclass	Date	Examiner
714	25		AR
714	38		AR
714	37		AR
382	153		AR
382	192		AR
715	726		AR
715	21-5		AR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text searched for		AR
Consulted with Primary Examiner Ba Hnyh and Raymond Bayerl.		AR